

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10658664	WEI, HUNG-SHAN
	Examiner	Art Unit
	FAWAAD HAIDER	3627

SEARCHED

Class	Subclass	Date	Examiner
705	08	7/9/08	FIH

SEARCH NOTES

Search Notes	Date	Examiner
See attached Search History	7/9/08	FIH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner